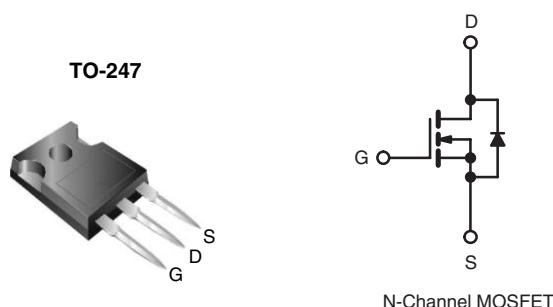


Power MOSFET

PRODUCT SUMMARY	
V _{DS} (V)	500
R _{D(on)} (Ω)	V _{GS} = 10 V 0.23
Q _g (Max.) (nC)	120
Q _{gs} (nC)	32
Q _{gd} (nC)	52
Configuration	Single



FEATURES

- Low Gate Charge Q_g Results in Simple Drive Requirement
- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS Directive 2002/95/EC


RoHS*
COMPLIANT

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptable Power Supply
- High Speed Power Switching

TYPICAL SMPS TOPOLOGIES

- Full Bridge Converters
- Power Factor Correction Boost

ORDERING INFORMATION

Package	TO-247
Lead (Pb)-free	IRFP22N50APbF SiHFP22N50A-E3
SnPb	IRFP22N50A SiHFP22N50A

ABSOLUTE MAXIMUM RATINGS T_C = 25 °C, unless otherwise noted

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V _{DS}	500	
Gate-Source Voltage	V _{GS}	± 30	V
Continuous Drain Current	V _{GS} at 10 V	22	A
		14	
Pulsed Drain Current ^a	I _{DM}	88	
Linear Derating Factor		2.2	W/°C
Single Pulse Avalanche Energy ^b	E _{AS}	1180	mJ
Repetitive Avalanche Current ^a	I _{AR}	22	A
Repetitive Avalanche Energy ^a	E _{AR}	28	mJ
Maximum Power Dissipation	P _D	277	W
Peak Diode Recovery dV/dt ^c	dV/dt	4.8	V/ns
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature)	for 10 s	300 ^d	
Mounting Torque	6-32 or M3 screw	10	lbf · in
		1.1	N · m

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Starting T_J = 25 °C, L = 4.87 mH, R_g = 25 Ω, I_{AS} = 22 A (see fig. 12).

c. I_{SD} ≤ 22 A, dI/dt ≤ 190 A/μs, V_{DD} ≤ V_{DS}, T_J ≤ 150 °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

THERMAL RESISTANCE RATINGS

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	40	°C/W
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.45	

SPECIFICATIONS T_J = 25 °C, unless otherwise noted

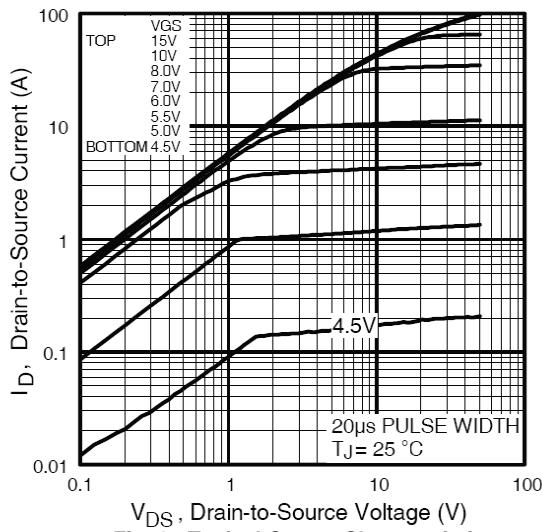
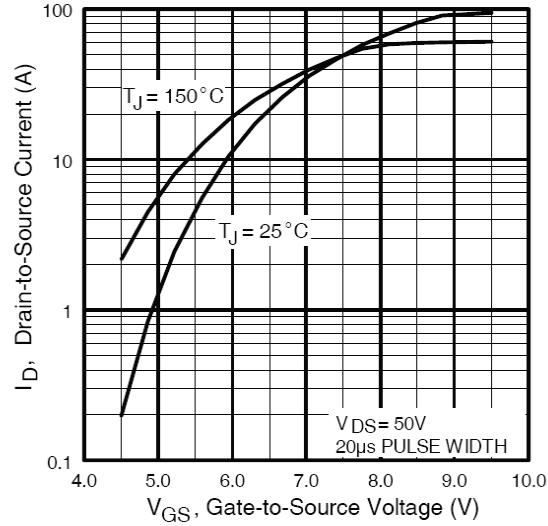
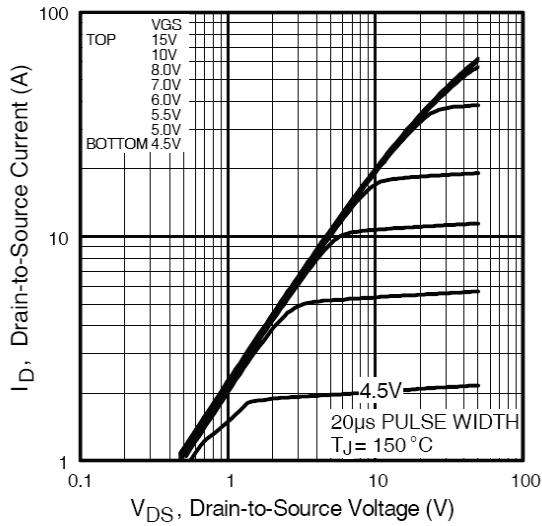
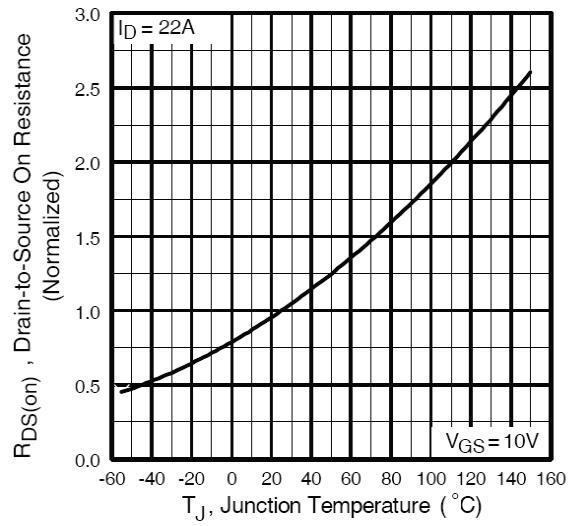
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA		500	-	-	V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	Reference to 25 °C, I _D = 1 mA		-	0.55	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA		2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 30 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 500 V, V _{GS} = 0 V		-	-	25	μA
		V _{DS} = 400 V, V _{GS} = 0 V, T _J = 125 °C		-	-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 13 A ^b	-	-	0.23	Ω
Forward Transconductance	g _{fs}	V _{DS} = 50 V, I _D = 13 A ^b		12	-	-	S
Dynamic							
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5		-	3450	-	pF
Output Capacitance	C _{oss}			-	513	-	
Reverse Transfer Capacitance	C _{rss}			-	27	-	
Output Capacitance	C _{oss}	V _{GS} = 0 V	V _{DS} = 1.0 V, f = 1.0 MHz		4935		pF
			V _{DS} = 400 V, f = 1.0 MHz		137		
Effective Output Capacitance	C _{oss eff.}		V _{DS} = 0 V to 400 V ^c		264		
Total Gate Charge	Q _g	V _{GS} = 10 V	I _D = 22 A, V _{DS} = 400 V, see fig. 6 and 13 ^b	-	-	120	nC
Gate-Source Charge	Q _{gs}			-	-	32	
Gate-Drain Charge	Q _{gd}			-	-	52	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 250 V, I _D = 22 A, R _G = 4.3 Ω, R _D = 11 Ω, see fig. 10 ^b		-	26	-	ns
Rise Time	t _r			-	94	-	
Turn-Off Delay Time	t _{d(off)}			-	47	-	
Fall Time	t _f			-	47	-	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	22	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	88	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 22 A, V _{GS} = 0 V ^b		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 22 A, dI/dt = 100 A/μs ^b		-	570	850	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	6.1	9.2	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.

c. C_{oss eff.} is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS}.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Fig. 1 - Typical Output Characteristics

Fig. 3 - Typical Transfer Characteristics

Fig. 2 - Typical Output Characteristics

Fig. 4 - Normalized On-Resistance vs. Temperature

IRFP22N50A, SiHFP22N50A



Vishay Siliconix

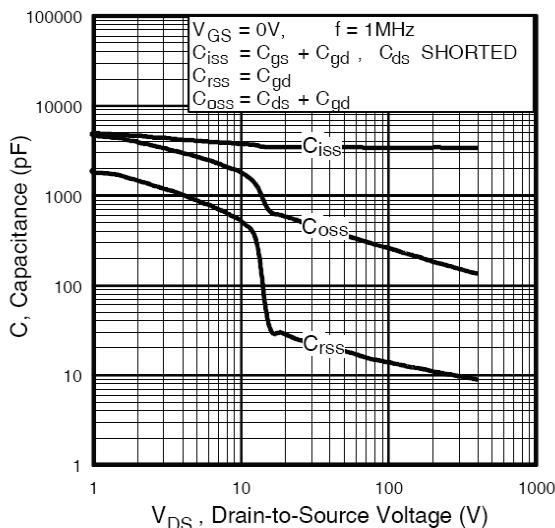


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

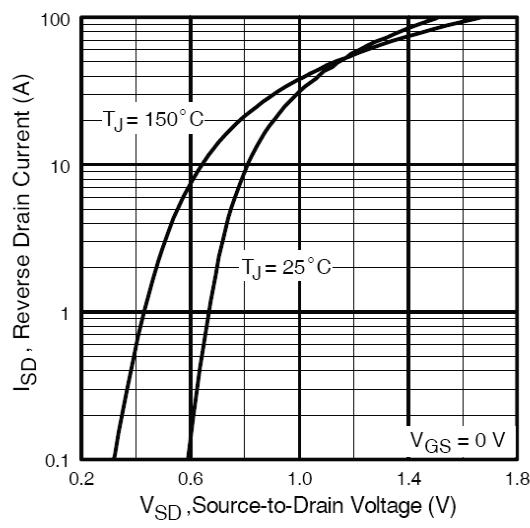


Fig. 7 - Typical Source-Drain Diode Forward Voltage

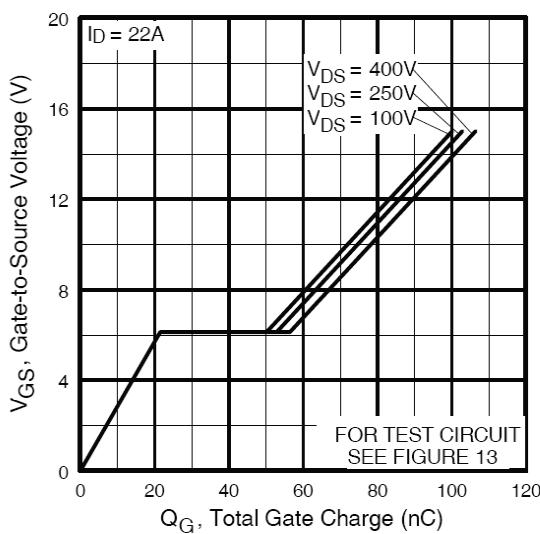


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

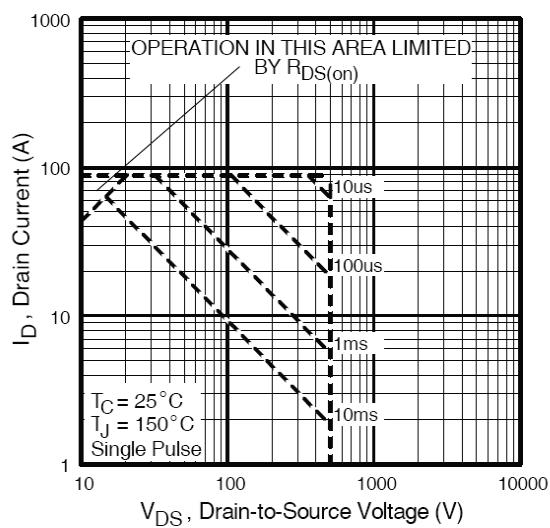
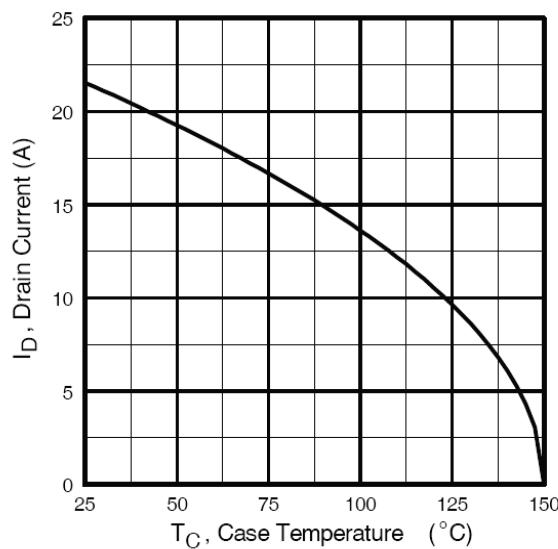
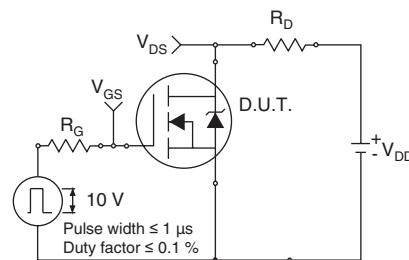
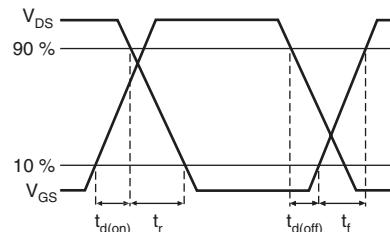
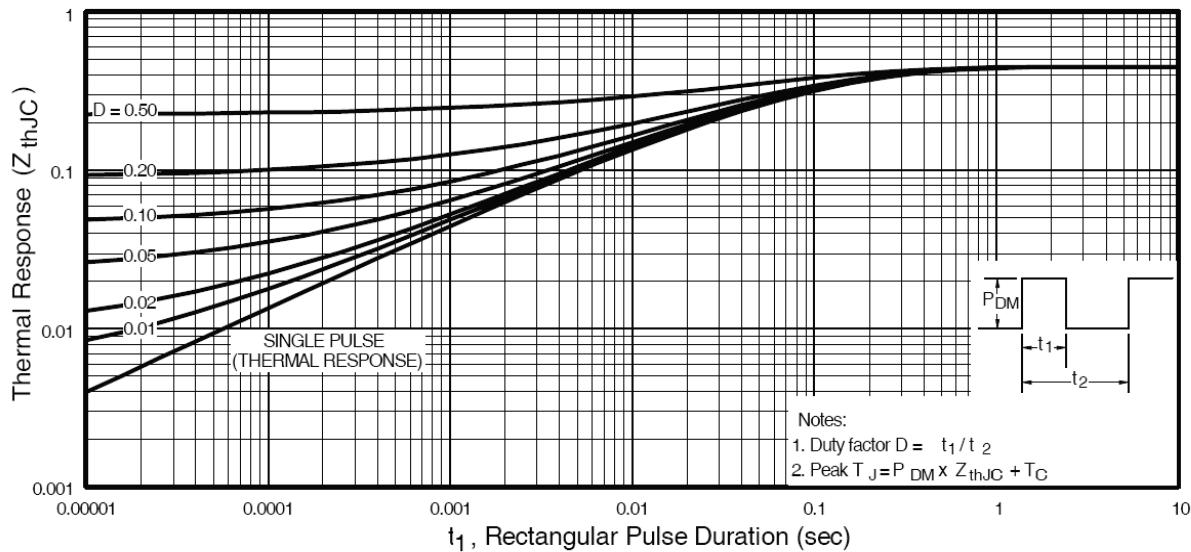
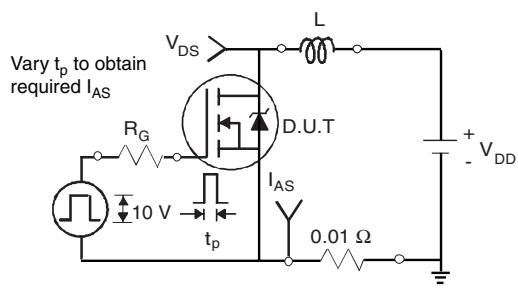
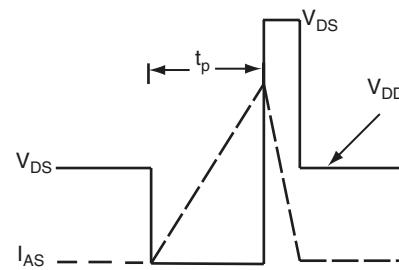


Fig. 8 - Maximum Safe Operating Area


Fig. 9 - Maximum Drain Current vs. Case Temperature

Fig. 10a - Switching Time Test Circuit

Fig. 10b - Switching Time Waveforms

Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

IRFP22N50A, SiHFP22N50A

Vishay Siliconix

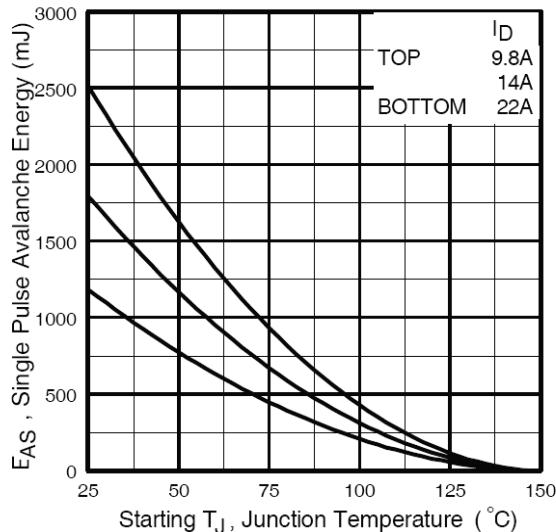


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

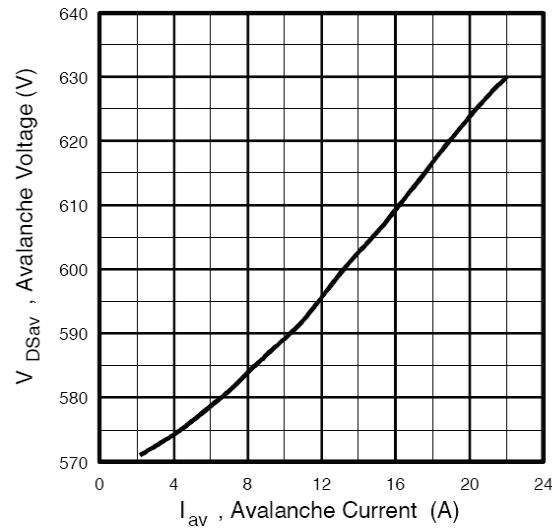


Fig. 12d - Typical Drain-to-Source Voltage vs. Avalanche Current

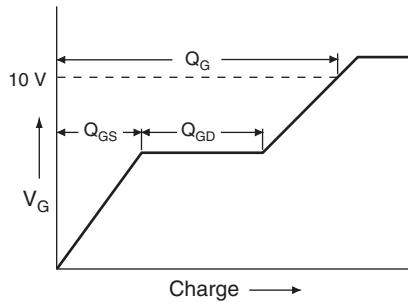


Fig. 13a - Basic Gate Charge Waveform

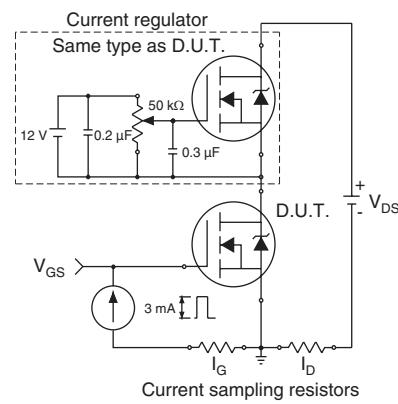
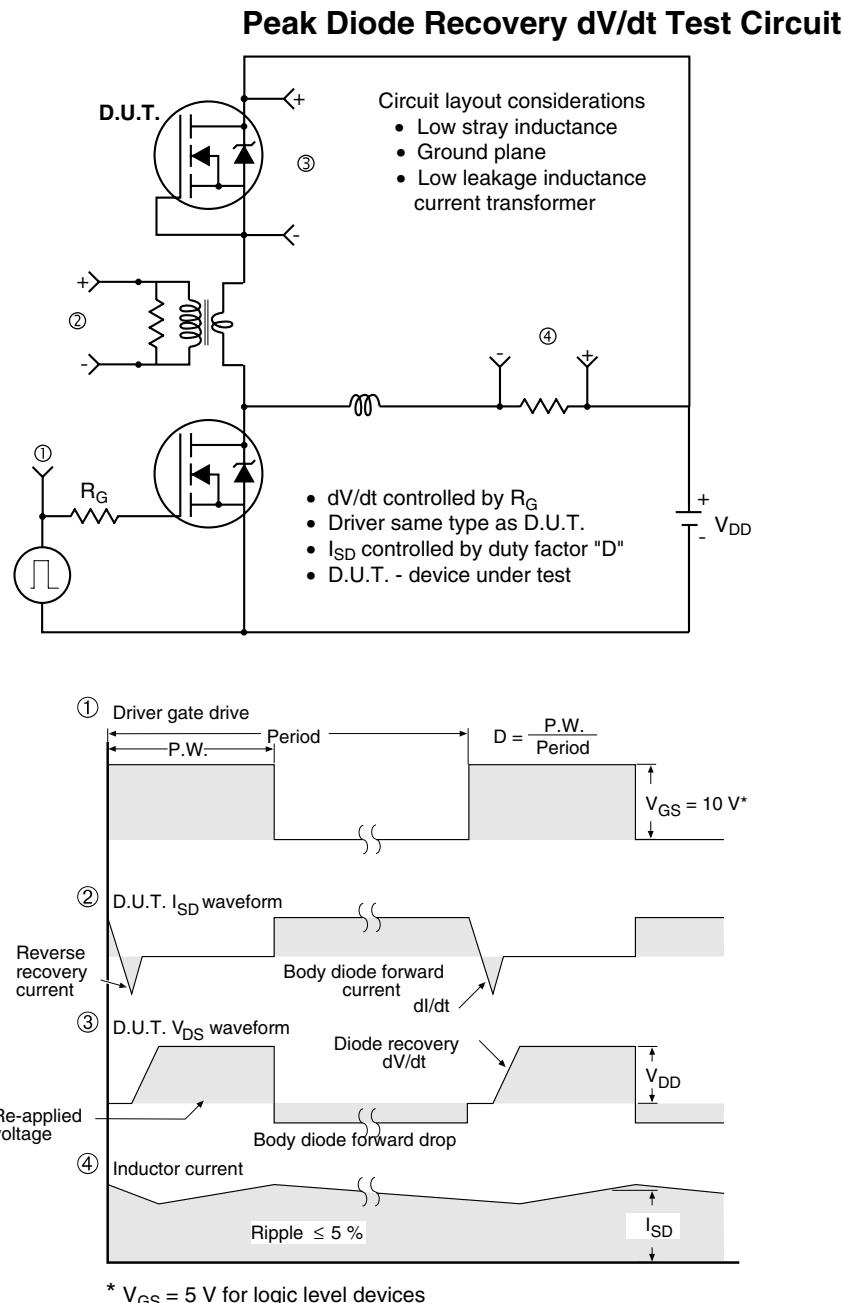


Fig. 13b - Gate Charge Test Circuit


Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91207.



Disclaimer

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.